Application/Control No. Applicant(s)/Patent Under Reexamination 10/720,853 CHANG ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2182 Scott Sun **U.S. PATENT DOCUMENTS Document Number** Date Name Classification 'Country Code-Number-Kind Code MM-YYYY US-2004/0225832 11-2004 Huang, Wen Yen 711/105 Α В US-С US-US-D US-Ε F US-G US-US-Н US-1 US-US-K US-L US-M FOREIGN PATENT DOCUMENTS Document Number Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

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